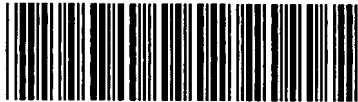


**Search Notes**

Application/Control No.

10/644,155

Examiner

Frank Duong

Applicant(s)/Patent under  
Reexamination

WEYMAN ET AL.

Art Unit

2616

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST SEARCH (see printout)	5/8/2007	FD
INVENTORSHIP SEARCH (see printout)	5/7/2007	FD
IEEE/INTERNET SEARCH	5/7/2007	FD